Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/721,518	YAMAYA ET AL.
Examiner	Art Unit
Matthew J. Kasztejna	3739

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Class	Subclass	Date	Examiner
updated	all	3/31/2006	MJK
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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